

## UNITED STATES PATENT AND TRADEMARK OFFICE



APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
10/711,444	09/20/2004	Chao-Fu Weng	8012-US-PA-1	5443
31561	7590 04/06/2005		EXAMINER	
JIANQ CHYUN INTELLECTUAL PROPERTY OFFICE 7 FLOOR-1, NO. 100			MANDALA, VICTOR A	
	T ROAD, SECTION 2		ART UNIT	PAPER NUMBER
,	·		2826	
TAIWAN			DATE MAILED: 04/06/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)
	10/711,444	WENG, CHAO-FU
Office Action Summary	Examiner	Art Unit
	Victor A. Mandala Jr.	2826
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	correspondence address
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a reply If NO period for reply is specified above, the maximum statutory period w  - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be ting within the statutory minimum of thirty (30) day rill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	nely filed s will be considered timely. the mailing date of this communication. D (35 U.S.C. § 133).
Status		
1) Responsive to communication(s) filed on 20 Se	eptember 2004.	
2a) This action is <b>FINAL</b> . 2b) ⊠ This	action is non-final.	
3) Since this application is in condition for allowar closed in accordance with the practice under E	•	
Disposition of Claims		
4) ☐ Claim(s) 1-14 is/are pending in the application. 4a) Of the above claim(s) is/are withdraw 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 1-14 is/are rejected. 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or	vn from consideration.	
Application Papers		
9) The specification is objected to by the Examine	r.	
10) The drawing(s) filed on is/are: a) acce	epted or b) $\square$ objected to by the I	Examiner.
Applicant may not request that any objection to the	drawing(s) be held in abeyance. See	e 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correcti	· · · · · · · · · · · · · · · · · · ·	•
Priority under 35 U.S.C. § 119		
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a) All b) Some * c) None of:  1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the priority application from the International Bureau * See the attached detailed Office action for a list of	s have been received. s have been received in Applicati ity documents have been receive ı (PCT Rule 17.2(a)).	on No ed in this National Stage
Attachment(s)	A\	(PTO 412)
1) X Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	4) 🔛 Interview Summary Paper No(s)/Mail Da	ate
Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date	5)  Notice of Informal P 6)  Other:	atent Application (PTO-152)

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## **DETAILED ACTION**

## Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-14 are rejected under 35 U.S.C. 102(b) as being anticipated by U.S. Patent No. 6,066,877 Williams et al.

- 1. Referring to claim 1, a chip structure with bumps comprising; a chip having an active surface, (Figure 8 #70 & 71), and at least a bonding pad, (Figure 8 #73), wherein the bonding pad, (Figure 8 #73), is formed on the active surface, (Figure 8 #70 & 71); and at least a bump, (Figure 8 #80A & 80B), disposed on the bonding pad, (Figure 8 #73), and the bump, (Figure 8 #80A & 80B), comprising: a medium layer, (Figure 8 #80A), disposed on the bonding pad, (Figure 8 #73), wherein a material of the medium layer, (Figure 8 #80A), includes zinc, (Col. 5 Line 59); a bump body, (Figure 8 #80B), disposed on the medium layer, (Figure 8 #80A), wherein a material of the bump body, (Figure 8 #80B), includes nickel, and a bump body passivation layer, (Figure 8 #80C), covering the bump body, (Figure 8 #80B), except for a portion of the bump body, (Figure 8 #80B), that connects to the medium layer, (Figure 8 #80A), wherein a material of the bump body passivation layer includes gold, (Figure 8 #80C).
- 2. Referring to claim 2, a chip structure with bumps, wherein a height of the bump is about 5 to 10 microns, (Col. 5 Line 52).

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3. Referring to claim 3, a chip structure with bumps, wherein a thickness of the bump body passivation layer is about 1 to 3 microns, (Col. 6 Lines 3-4).

- 4. Referring to claim 4, a bump suitable to be disposed on a chip, wherein the chip has an active surface, (Figure 8 #70 & 71), and at least a bonding pad, (Figure 8 #73), that exposes the active surface, (Figure 8 #70 & 71), and the bump, (Figure 8 #80A & 80B), comprising: a medium layer, (Figure 8 #80A), disposed on the bonding pad, (Figure 8 #73); and a bump body, (Figure 8 #80B), disposed on the medium layer, (Figure 8 #80A), wherein a material of the bump body, (Figure 8 #80B), includes nickel.
- 5. Referring to claim 5, a bump, further comprising a bump body passivation layer, (Figure 8 #80C), covering the bump body except for a portion of the bump body, (Figure 8 #80B), that connects to the medium layer, (Figure 8 #80A).
- 6. Referring to claim 6, a bump, wherein a material of the bump body passivation layer includes gold, (Figure 8 #80C).
- 7. Referring to claim 7, a bump, wherein a thickness of the bump body passivation layer, (Figure 8 #80C), is about 1 to 3 microns, (Col. 6 Lines 3-4).
- 8. Referring to claim 8, a bump, wherein a height of the bump is about 5 to 10 microns, (Col. 5 Line 52).
- 9. Referring to claim 9, a bump, wherein a material of the medium layer, (Figure 8 #80A), includes zinc, (Col. 5 Line 59).
- 10. Referring to claim 10, a bump suitable to be disposed on a chip, wherein the chip has an active surface, (Figure 8 #70 & 71), and at least a bonding pad, (Figure 8 #73), that exposes the active surface, (Figure 8 #70 & 71), and the bump, (Figure 8 #80A & 80B), comprising: a medium layer, (Figure 8 #80A), disposed on the bonding pad,

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(Figure 8 #73), wherein a material of the medium layer, (Figure 8 #80A), includes zinc, (Col. 5 Line 59); and a bump body, (Figure 8 #80B), disposed on the medium layer, (Figure 8 #80A).

- Referring to claim 11, a bump, further comprising a bump body passivation layer, (Figure 8 #80C), covering the bump body, (Figure 8 #80B), except for a portion of the bump body, (Figure 8 #80B), that connects to the medium layer, (Figure 8 #80A).
- 12. Referring to claim 12, a bump, wherein a material of the bump body passivation layer includes gold, (Figure 8 #80C).
- 13. Referring to claim 13, a bump, wherein a thickness of the bump body passivation layer is about 1 to 3 microns, (Col. 6 Lines 3-4).
- 14. Referring to claim 14, a bump, wherein a height of the bump is about 5 to 10 microns, (Col. 5 Line 52).

## Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Victor A. Mandala Jr. whose telephone number is (571) 272-1918. The examiner can normally be reached on Monday through Thursday from 8am till 6pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan J. Flynn can be reached on (571) 272-1915. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

VAMJ 3/31/05 NATHAN J FLYNN 130RY PATENT EXAMINER 140 JULY GY CENTER 2800